

# AM3962NE-VB Datasheet Dual N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
60	0.048 at V <sub>GS</sub> = 10 V	4.2	4.9		
00	0.060 at V <sub>GS</sub> = 4.5 V	3.6	4.5		

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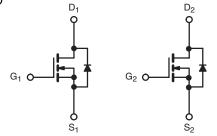
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

### RoHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- CCFL Inverter
- DC/DC Converter
- HDD



N-Channel MOSFET

N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T	$_{\rm A}$ = 25 °C, unless other	rwise noted)			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	$V_{DS}$	60	V		
Gate-Source Voltage	$V_{GS}$	± 20	]		
	T <sub>C</sub> = 25 °C		4.2		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	l <sub>D</sub>	3.6		
Continuous Brain Guiterit (1) = 130 G)	T <sub>A</sub> = 25 °C	טי	4.0 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	1	3.0 <sup>b, c</sup>		
Pulsed Drain Current (10 μs Pulse Width)		I <sub>DM</sub>	16	Α	
Source-Drain Current Diode Current	$T_C = 25  ^{\circ}C$	Is	2.6		
Source-Drain Guitent blode Guitent	T <sub>A</sub> = 25 °C	'5	1.6 <sup>b, c</sup>		
Pulsed Source-Drain Current	I <sub>SM</sub>	16			
Single Pulse Avalanche Current  L = 0.1 mH		I <sub>AS</sub>	10		
Single Pulse Avalanche Energy	L = 0.1 IIII1	E <sub>AS</sub>	5		
	$T_C = 25  ^{\circ}C$		2.8		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	1.8	w	
Maximum i ower bissipation	T <sub>A</sub> = 25 °C		2 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		1.28 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Тур.	Max.	Unit			
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	49	62.5	°C/W		
Maximum Junction-to-Foot (Drain)	Steady-State	$R_{thJF}$	30	40	0,11		

#### Notes:

- a. Based on T<sub>C</sub> = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 120  $^{\circ}\text{C/W}.$



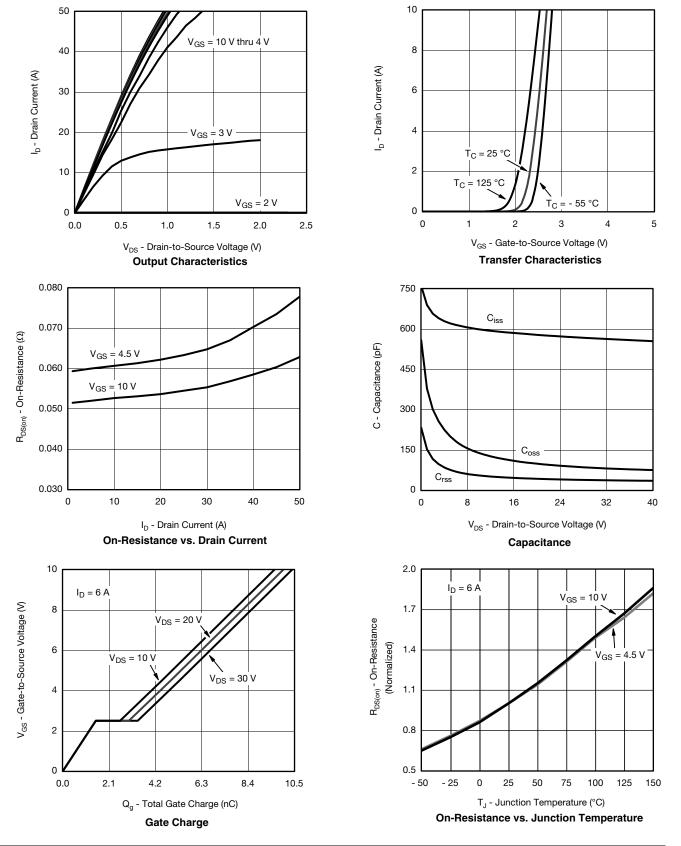
Parameter	Symbol	Test Conditions	Min.	Typ. <sup>a</sup>	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J. 050A		49		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I <sub>D</sub> = 250 μA		- 5.2		
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.5	V
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			100	nA
Zana Oaka Walla ya Busin Ouwani	I <sub>DSS</sub>	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V			1	
Zero Gate Voltage Drain Current		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ
On-State Drain Current <sup>b</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> = 5 V, V <sub>GS</sub> = 10 V	20			Α
	В	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.0A				Ω
Drain-Source On-State Resistance <sup>b</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 3.0 \text{A}$				
Forward Transconductance <sup>b</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 4.0A		35		S
Dynamic <sup>a</sup>	•			'		,
Input Capacitance	C <sub>iss</sub>			580		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ MHz}$		100		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	1		42		
Total Gate Charge	Qg	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.0 A		10	15	nC
				4.9	7.4	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 4.0 \text{ A}$		1.5		
Gate-Drain Charge	Q <sub>gd</sub>	1		1.5		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	0.6	2.7	5.4	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			7	14	
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_{L} = 2 \Omega$		9	18	- -
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 4.0 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		16	32	
Fall Time	t <sub>f</sub>	1		8	16	
Turn-On Delay Time	t <sub>d(on)</sub>			12	24	ns
Rise Time	t <sub>r</sub>	$V_{DD} = 20 \text{ V}, R_{L} = 2 \Omega$		10	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 7.0 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		13	26	_
Fall Time	t <sub>f</sub>	1		8	16	
Drain-Source Body Diode Characteristi	cs					l.
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			2.6	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				50	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 3 A		0.77	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			15	30	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1		7.5	15	nC
Reverse Recovery Fall Time	$I_{\rm F} = 5  \text{A. dl/dt} = 100  \text{A/us.}  I_{\rm T} = 25  \text{C}$			9		
Reverse Recovery Rise Time		t <sub>b</sub>		6		ns

#### Notes:

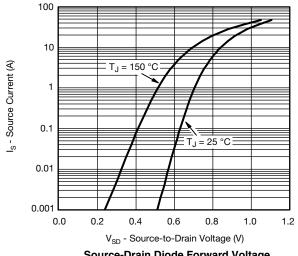
- a. Guaranteed by design, not subject to production testing. b. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.

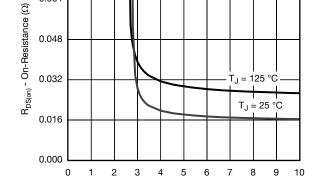
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.











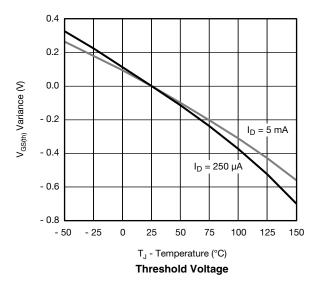
0.080

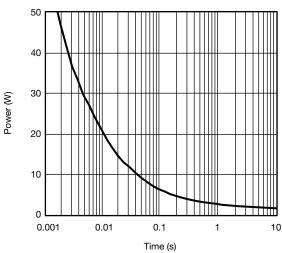
0.064

 $I_D = 4.0 A$ 

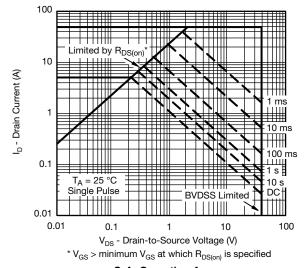
 $V_{GS}$  - Gate-to-Source Voltage (V) On-Resistance vs. Gate-to-Source Voltage





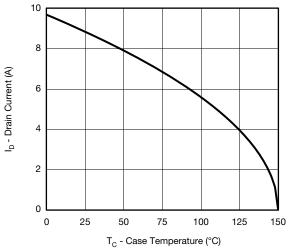


Single Pulse Power, Junction-to-Ambient

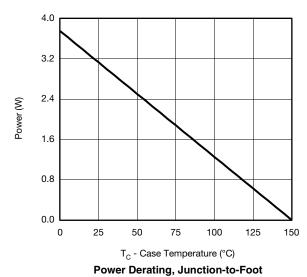


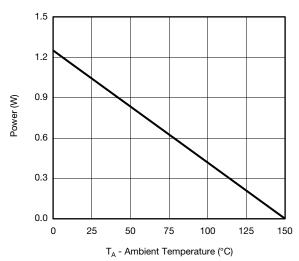
Safe Operating Area







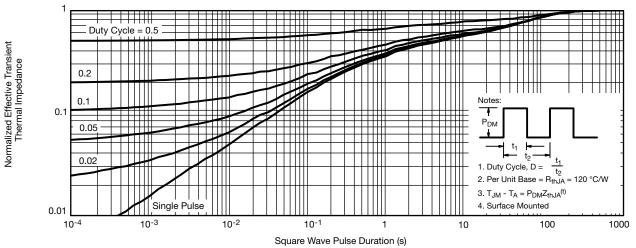




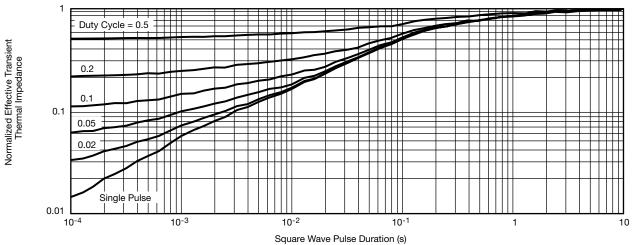
Power Derating, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

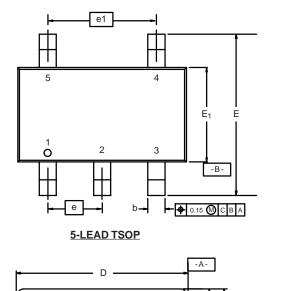


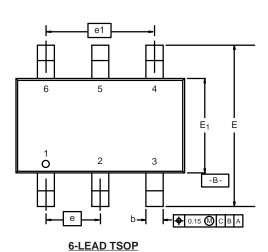
Normalized Thermal Transient Impedance, Junction-to-Foot

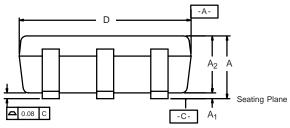


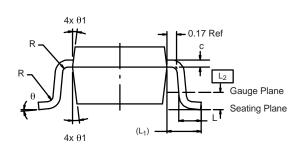
TSOP: 5/6-LEAD

**JEDEC Part Number: MO-193C** 





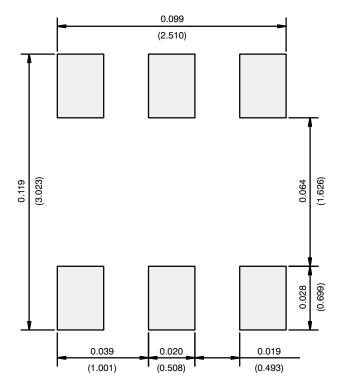




	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
$A_1$	0.01	-	0.10	0.0004	-	0.004	
A <sub>2</sub>	0.90	-	1.00	0.035	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	2.70	2.85	2.98	0.106	0.112	0.117	
E <sub>1</sub>	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.95 BSC			0.0374 BSC			
e <sub>1</sub>	1.80	1.90	2.00	0.071	0.075	0.079	
L	0.32	-	0.50	0.012	-	0.020	
L <sub>1</sub>	0.60 Ref			0.024 Ref			
L <sub>2</sub>	0.25 BSC			0.010 BSC			
R	0.10	-	-	0.004	-	-	
θ	0°	4°	8°	0°	4°	8°	
$\theta_1$	7° Nom			7° Nom			
ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540							



#### **RECOMMENDED MINIMUM PADS FOR TSOP-6**



Recommended Minimum Pads Dimensions in Inches/(mm)



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